N-Channel SUPERFET[®] III Easy-Drive MOSFET

650 V, 10 A, 360 m Ω

Description

SuperFET III MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate.

Consequently, SuperFET III MOSFET Easy-drive series helps manage EMI issues and allows for easier design implementation.

Features

- 700 V @ $T_J = 150^{\circ}C$
- Typ. $R_{DS(on)} = 310 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. $Q_g = 18 \text{ nC}$)
- Low Effective Output Capacitance (Typ. Coss(eff.) = 173 pF)
- 100% Avalanche Tested
- These Devices are Pb-Free and are RoHS Compliant

Applications

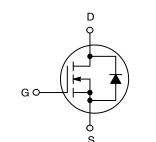
- Computing / Display Power Supplies
- Telecom / Server Power Supplies
- Industrial Power Supplies
- Lighting / Charger / Adapter

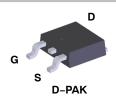


ON Semiconductor®

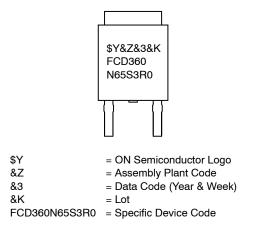
www.onsemi.com

V _{DSS}	V _{DSS} R _{DS(ON)} MAX I _D MAX		
650 V	$360 \text{ m}\Omega$	10 A	





MARKING DIAGRAM



ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

Symbol	Parameter	FCD360N65S3R0	D Unit		
V _{DSS}	DSS Drain to Source Voltage		650	V	
V _{GSS}	Gate to Source Voltage – DC		±30	V	
		– AC (f > 1 Hz)	±30	V	
ID	Drain Current:	– Continuous (T _C = 25°C)	10	А	
		– Continuous (T _C = 100°C)	6	1	
I _{DM}	Drain Current:	nt: - Pulsed (Note 1)		А	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		40	mJ	
I _{AS}	Avalanche Current (Note 2)		2.1	А	
E _{AR}	Repetitive Avalanche Energy (Note 1)		0.83	mJ	
dv/dt	MOSFET dv/dt		100	V/ns	
	Peak Diode Recovery dv/dt (Note 3)		20		
PD	Power Dissipation	(T _C = 25°C)	83	W	
	Derate Above 25°C		0.67	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		–55 to +150	°C	
ΤL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 seconds		300	°C	

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, Unless otherwise noted)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	FCD360N65S3R0	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max.	1.5	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	

PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Marking	Package	Packing Method	Reel Size	Tape Width	Quantity
FCD360N65S3R0	FCD360N65S3R0	TO-252	Tape and Reel	330 mm	16 mm	2500 Units

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
FF CHARACT	ERISTICS		•	•	•	
BV _{DSS}	Drain to Source Breakdown Voltage	V_{GS} = 0 V, I _D = 1 mA, T _J = 25°C	650	-	-	V
		V_{GS} = 0 V, I _D = 1 mA, T _J = 150°C	700	-	-	V
$\Delta \text{BV}_{\text{DSS}} / \Delta \text{T}_{\text{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 1$ mA, Referenced to 25°C	-	0.68	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 650 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	-	1	μΑ
		V_{DS} = 520 V, T_{C} = 125°C	-	0.58	-	
I _{GSS}	Gate to Body Leakage Current	V_{GS} = ± 30 V, V_{DS} = 0 V	_	-	±100	nA
N CHARACTE	RISTICS	•	•			•
V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	2.5	-	4.5	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 5 A	-	310	360	mΩ
9 FS	Forward Transconductance	V _{DS} = 20 V, I _D = 5 A	-	6	-	S
YNAMIC CHA	RACTERISTICS	•	•			•
C _{iss}	Input Capacitance	V_{DS} = 400 V, V_{GS} = 0 V, f = 1 MHz	-	730	-	pF
C _{oss}	Output Capacitance		_	15	-	pF
C _{oss(eff.)}	Effective Output Capacitance	V_{DS} = 0 V to 400 V, V_{GS} = 0 V	-	173	-	pF
C _{oss(er.)}	Energy Related Output Capacitance	V_{DS} = 0 V to 400 V, V_{GS} = 0 V	-	26	-	pF
Q _{g(tot)}	Total Gate Charge at 10V	$V_{DS} = 400 \text{ V}, \text{ I}_{D} = 5 \text{ A}, \text{ V}_{GS} = 10 \text{ V}$	-	18	-	nC
Q _{gs}	Gate to Source Gate Charge	(Note 4)	_	4.3	-	nC
Q _{gd}	Gate to Drain "Miller" Charge		_	7.6	-	nC
ESR	Equivalent Series Resistance	f = 1 MHz	-	1	-	Ω
WITCHING CH	IARACTERISTICS		·	•	•	
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 400 \text{ V}, \text{ I}_{D} = 5 \text{ A},$	-	12	-	ns
	T 0 Di T				1	

t _{d(on)}	Turn-On Delay Time	$V_{DD} = 400 \text{ V}, \text{ I}_{D} = 5 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{g} = 4.7 \Omega$	-	12	-	ns
t _r	Turn-On Rise Time	$v_{GS} = 10 \text{ V}, \text{ R}_{g} = 4.7 \text{ S2}$ (Note 4)	-	11	-	ns
t _{d(off)}	Turn-Off Delay Time		-	34	-	ns
t _f	Turn-Off Fall Time		_	10	-	ns

SOURCE-DRAIN DIODE CHARACTERISTICS

ا _S	Maximum Continuous Source to Drain Diode Forward Current		-	-	10	Α
I _{SM}	Maximum Pulsed Source to Drain Diode Forward Current		-	-	25	Α
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _{SD} = 5 A	-	-	1.2	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _{SD} = 5 A, dI _F /dt = 100 A/μs	-	241	-	ns
Q _{rr}	Reverse Recovery Charge	$di_{F}/dt = 100 \text{ A/} \mu \text{s}$	-	2.4	-	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 1. Repetitive rating: pulse-width limited by maximum junction temperature. 2. $I_{AS} = 2.1 \text{ A}$, $R_G = 25 \Omega$, starting $T_J = 25 ^{\circ}C$. 3. $I_{SD} \le 5A$, di/dt $\le 200 \text{ A}/\mu\text{S}$, $V_{DD} \le 400 \text{ V}$, starting $T_J = 25 ^{\circ}C$. 4. Essentially independent of operating temperature typical characteristics.

TYPICAL PERFORMANCE CHARACTERISTICS

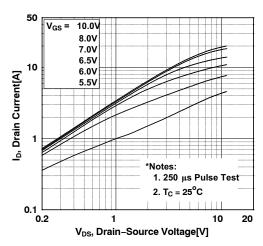


Figure 1. On-Region Characteristics

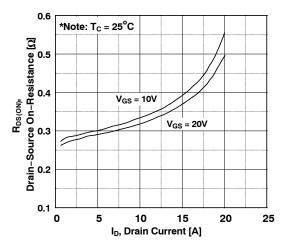


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

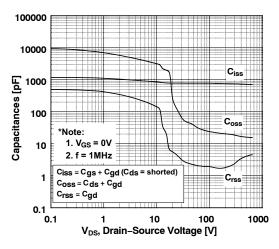


Figure 5. Capacitance Characteristics

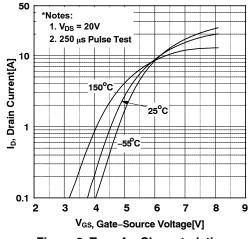


Figure 2. Transfer Characteristics

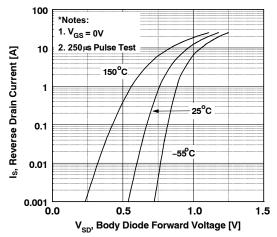


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

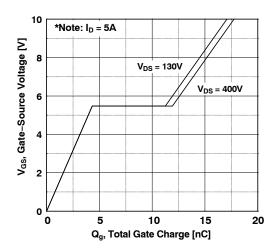
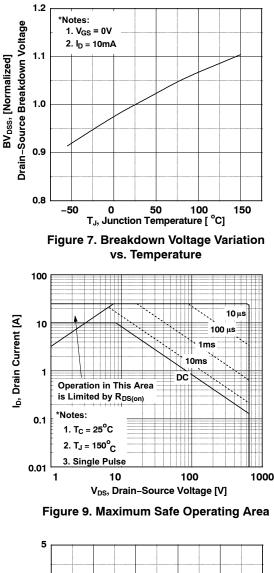


Figure 6. Gate Charge Characteristics

TYPICAL PERFORMANCE CHARACTERISTICS(Continued)



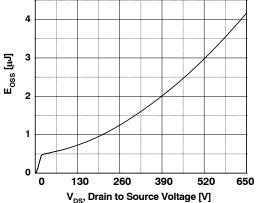
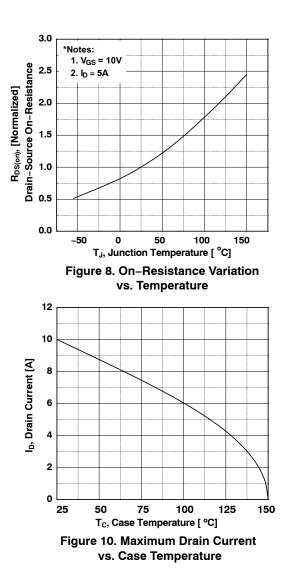
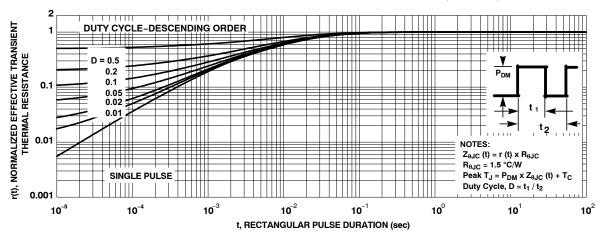


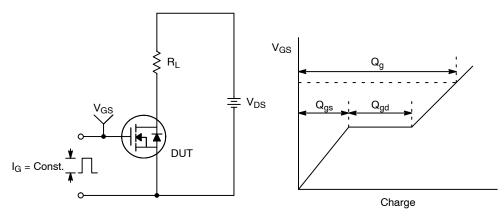
Figure 11. Eoss vs. Drain to Source Voltage





TYPICAL PERFORMANCE CHARACTERISTICS (Continued)







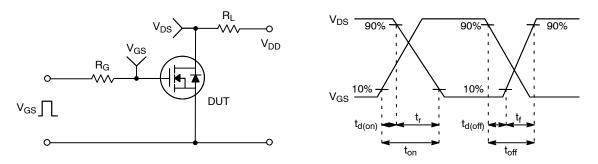


Figure 14. Resistive Switching Test Circuit & Waveforms

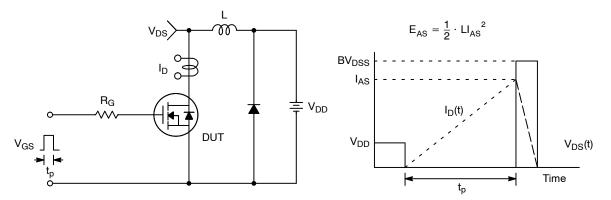


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms

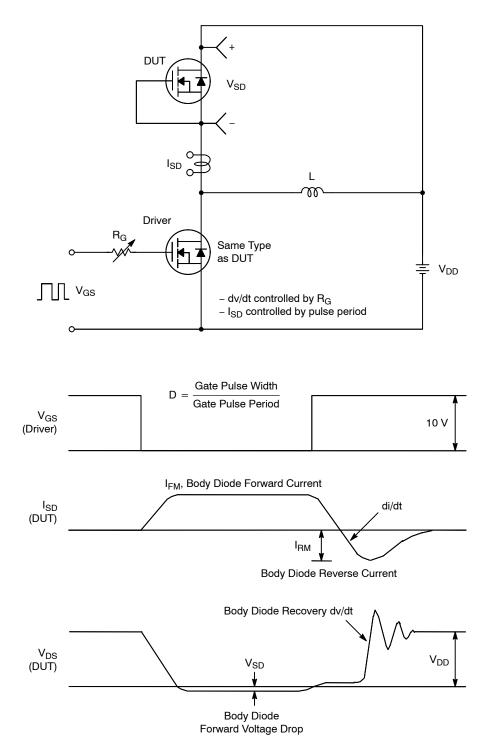
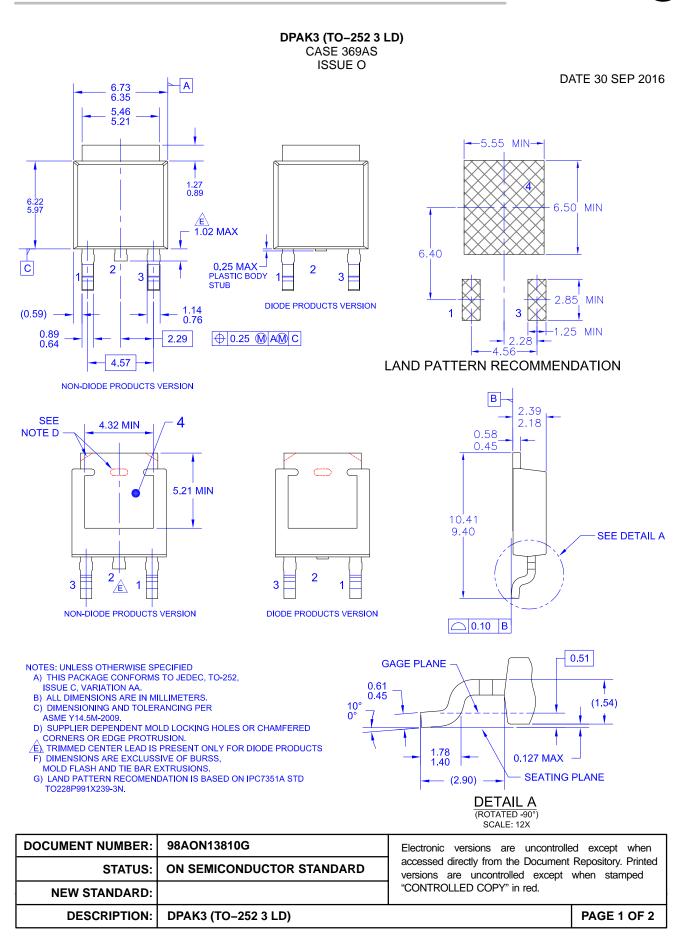


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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PAGE 2 OF 2

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